University of California, Davis College of Engineering Department of Electrical and Computer Engineering

EEC110B LABORATORY

I. OBJECTIVES AND GENERAL DIRECTIONS

The object of this laboratory is to reinforce the class lecture material, to teach the use of basic lab equipment, to teach laboratory skills, both general and troubleshooting, and to develop good experimental note-taking habits. You should purchase a bound lab notebook, preferably one with grid lines. All your pre-lab calculations, lab notes, data, and reports should be kept in the lab notebook. Lab reports need not repeat information that is published in this lab manual. However, your lab notebook and manual together should contain enough information to repeat the experiments. It will be graded at the end of each experiment.

To simplify the grading process, the lab manual includes a page to summarize the results from each experiment. These pages are included at the end of the lab manual. The appropriate summary page should be attached to the beginning of each lab report in your lab notebook. All requested information, both experimental results and calculated values, should be .copied onto this page. Any items left blank on the summary page will receive no credit. All corresponding calculations, required graphs and measurements of the lab along with any notes on the various circuits should appear in the report following the results page. Items appearing on the summary page without supporting calculations in the body of the report will also receive no credit. Any questions in the lab instructions should be answered at the END of the report.

II. PREPARATION FOR LABS

Time spent in the lab is to be used building and testing circuits, NOT learning the lab material and calculating circuit values. Read the labs and do any required calculations **before** coming to the lab.

III. BASIC LAB GROUND RULES

The work area in the lab must be left in the following condition at the end of the lab period:

- (1) All test equipment neatly placed on the bench.
- (2) All components replaced in their proper boxes or drawers in the storage cabinet.
- (3) Wires hung up neatly on the wall in their proper section.

IV. GRADING

Grading will be based on:

- (1) pre-lab calculations (where applicable)
- (2) lab report
- (3) student's lab skills
- (4) lab demonstrations

Acknowledgment - The class laboratory experiments were written by P. Chan, C. Eldering, P. Gray, P. Hurst, R. Levinson, S. Lewis, J. Pierret, and R. Spencer.

САЗО45, САЗО46 Турез

General-Purpose Transistor Arrays For Low Power Applications at Frequencies from DC through the VHF Range

THREE ISOLATED TRANSISTORS AND ONE DIFFERENTIALLY CONNECTED TRANSISTOR PAIR

The CA3045 and CA3046 each consist of five general-purpose glicon n-p-n transistors on a common monolithic substrate. Two of the transistors are internally connected to form a differentially-connected pair.

The transistors of the CA3045 and CA3046 are well suited to a wide variety of applications in low power systems in the DC through VHF range. They may be used as discrete transistors in conventional circuits. However, in addition, they provide the very significant inherent integrated circuit advantages of close electrical and thermal matching. The CA3045 is supplied in a 14-lead dual-in-line hermetic (welded-seal) ceramic package and the CA3045F in a 14-lead dual-in-line hermetic (frit-seal) ceramic package.

The CA3046 is electrically identical to the CA3045 but is supplied in a dual-in-line plastic package for applications requiring only a limited temperature range.

ABSOLUTE MAXIMUM RATINGS AT TA = 25°C	` CA3	045	CA3045F,		
Bour Dissignation	Each Transistor	Total Package	Each Transistor	Total Package	
Ta up to 55°C	-	_	[*] 300	750	mW'
$T_{A} > 55^{\circ}C$	-	_	Derate a	t 6.67	mW/ºC
T _A up to 75 ^o C	300	750	<u> </u>	. 	mW
T _A > 75°C	Derate	at 8	· _	. —	mW/ ⁰ C
Collector-to-Emitter Voltage, VCEO	15	· 	15	-	v
Collector-to-Base Voltage, VCBO	20	-	20	-	v
Collector-to-Substrate Voltage, VCIO	20	-	20,	-	v
Emitter-to-Base Voltage, VEBO	5	-	5	-	V
Temperature Range: Operating	-55 to 65 to	+125 +150	-55 to -65 to	9 +125 9 +150	°C °C
At distance 1/16 ±1/32" (1.59 ±0.79 mm)	13	ee .	10	86	°C
*The collector of each transition of the CA3045 CA3046 is isolated from the substrate by an int dide. The substrate (terminal 13) must be come	and to t egral main rected for a	he most nega ntain isolation normal transist	tive point in th between transi or action.	e external cli istors and to	cuit to provide

ELECTRICAL CHARACTERISTICS, at TA = 25°C

Characteristics apply for each transistor in the CA3045 and CA3046 as specified.

CHARACTERISTICS	SYMBOLS	SPECIAL TEST CONDITIONS		UNITS		
			MIN.	TYP.	MAX.	
STATIC CHARACTERISTICS						
Collector-to-Base Breakdown Voltage	V(BR)CBO	I _C =10 μΑ, I _E = 0	20	60	•.	V .
Collector-to-Emitter Breakdown Voltage	V(BR)CEO	I _C = 1 mA, I _B = 0	15	24	•	V .
Collector-to-Substrate Breakdown Voltage	V(BR)CIO	$I_{\rm C} = 10 \mu {\rm A}, I_{\rm CI} = 0$	20	60	•	V
Emitter-to-Base Breakdown Voltage	V(BR)EBO	$I_{\rm E} = 10\mu{\rm A}, I_{\rm C} = 0$	5	1	•	۷.
Collector-Cutoff Current	ICB0	$V_{CB} = 10 V, I_E = 0$	•	0.002	40	nA
Collector-Cutoff Current	ICE0	V _{CE} = 10 V, 1 _B = 0	•	See curve	0.5	μA
Static Forward Current-Transfer Ratio (Static Beta)	ħFE	$V_{CE} = 3V \begin{cases} i_C = 10 \text{ mA} \\ i_C = 1 \text{ mA} \\ i_C = 10 \mu \text{A} \end{cases}$	40	100 100 54	•	•
Input Offset Current for Matched Pair Q_1 and Q_2 . $1_{10_1} - 1_{10_2}$		V _{CE} = 3 V, I _C = 1 mA	•	0.3	2	μA
Base-to-Emitter Voltage	V _{BE}	$V_{CE} = 3 V \begin{cases} t_E = 1 \text{ mA} \\ t_E = 10 \text{ mA} \end{cases}$	•••	0.715 0.800	•	v
Magnitude of input Offset Voltage for Differential Pair $V_{BE_1} - V_{BE_2}$		V _{CE} = 3 V, I _C = 1 mA	•	0.45	5	mV .
Magnitude of Input Offset Voltage for Iso- lated Transistors $ V_{BE_3} \cdot V_{BE_4} $ $ V_{BE_4} \cdot V_{BE_5} $, $ V_{BE_5} - V_{BE_3} $		V _{CE} = 3 V, I _C = 1 mA		0.45	5	mV
Temperature Coefficient of Base-to-Emitter Voltage		$V_{CE} = 3 V_{\rm r} I_{\rm C} = 1 \rm mA$		-1.9		mV ⁰C
Collector-to-Emitter Saturation Voltage	VCES	$I_{B} = 1 \text{ mA}, I_{C} = 10 \text{ mA}$	•	0.23	·	۷
Temperature Coefficient: Magnitude of Input-Offset Voltage		V _{CE} 3 V, 1 _C 1 mA	•	1.1	•	<i>µ</i> ,v°C

Fig. 1 - Schematic diagram. Note that the substrate (pin 13) must be connected to the lowest supply voltage.

FEATURES

- Two matched pairs of transistors YBE matched ±5 mV
 - Input offset current 2 µA max. at IC = 1 mA
- 5 general purpose monolithic transistors
- Operation from DC to 120 MHz
- Wide operating current range
- Low noise figure - 3.2 dB typ. at 1 kHz
- Full military temperature range for CA3045 -55 to +125°C
- The CA3045 is available in a sealed-junction Beam-Lead version (CA3045L). For further information see File No. 515, "Beam-Lead Devices for Hybrid Circuit Applications".

APPLICATIONS

- General use in all types of signal processing systems operating anywhere in the frequency range from DC to VHF
- Custom designed differential amplifiers
- Temperature compensated amplifiers
- See RCA Application Note, ICAN-5296 "Application of the RCA-CA3018 Integrated Circuit Transistor Array" for suggested applications.

STATIC CHARACTERISTICS



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LINEAR INTEGRATED CIRCUITS

CA3045, CA3046 Types

ELECTRICAL CHARACTERISTICS, of $T_A = 25^{\circ}C$

				LIMITS				
CHARACTERISTICS	SYMBOLS	SPECIAL TEST CONDITIONS		Type CA3045 Type CA3046		UNITS		
			MIN,	TYP.	MAX.			
DYNAMIC CHARACTERISTICS								
Low-Frequency Noise Figure	NF	f = 1 kHz, V _{CE} = 3V, I _C = 100 μ A Source Resistance = 1 k Ω		3.25	·	dB		
Low-Frequency, Small-Signal Equivalent-Circuit Characteristics:								
Forward Current-Transfer Ratio	hfe		•	110	•	-		
Short-Circuit Input Impedance	h _{ie}	1 [3.5	·	kúΣ		
Open-Circuit Output Impedance	hoe	$f = 1 \text{ kHz}, V_{CE} = 3 \text{ V}, I_{C} = 1 \text{ mA}$	•	15.6	-	μmho		
Open-Circuit Reverse Voltage-Transfer Ratio	h _{re}		•	1.8×10 ⁻⁴		•		
Admittance Characteristics:						,		
Forward Transfer Admittance	Y _{fe}	ł	-	31-j1.5	•	· .		
Input Admittance	Y _{ie}		•	0.3+j0.04	-	•		
Output Admittance	Y _{oe}	$\int I = I M \Pi Z, V C E = 3 V, I C = I I M A$		0.001+j0.03				
Reverse Transfer Admittance	Y _{re}		•	See curve	•	•		
Gain-Bandwidth Product	f _T	$V_{CE} = 3 V. I_{C} = 3 mA$	300	550	•	•		
Emitter-to-Base Capacitance	CEB	V _{EB} = 3 V, I _E = 0	•	0.6	· .	pF		
Collector-to-Base Capacitance	ССВ	$V_{CB} = 3 V, I_{C} = 0$	•	0.58	•	pF		
Collector-to-Substrate Capacitance	CCI	$V_{CS} = 3 V_1 I_C = 0$		2.8	•	pF		

STATIC CHARACTERISTICS



Fig.3 - Typical collector-to-emitter cutoff current vs ambient temperature for each transistor.



Fig.4 - Typical static forward current-transfer ratio and beta ratio for transistors Q_1 and Q_2 vs emitter current.



Fig.5 - Typical input offset current for matched transistor pair Q_1Q_2 vs collector current.



Fig.6 - Typical static base-to-emitter voltage characteristic and input offset voltage for differential pair and paired isolated transistors vs emitter current.









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CA3045, CA3046 Types



Fig.9(a) - Typical noise figure vs collector current.

DYNAMIC CHARACTERISTICS FOR EACH TRANSISTOR



Fig.9(b) - Typical noise figure vs collector current.





Fig.10 - Typical normalized forward current-transfer ratio, short-circuit input impedance, open-circuit output impedance, and open-circuit reverse voltage-transfer ratio vs collector current.



Fig.11 - Typical forward transfer admittance vs frequency.







Fig.13 - Typical output admittance vs frequency.







Fig.15 - Typical gain-bandwidth product vs collector current.

CA3086 General-Purpose N-P-N Transistor Array

ree Isolated Transistors and One Differentially— Connected Transistor Pair

For Low-Power Applications from DC to 120MHz

RCA-CA3086 consists of five general-purpose silicon n-p-n partitions on a common monolithic substrate. Two of the ganistors are internally connected to form a strategistic connected to form a differentially-connected pair.

transistors in conventional circuits. However, they also provide the very significant inherent advantages unique to integrated circuits, such as compactness, ease of physical handling and thermal matching.

package. The CA3086F is supplied in a 14-lead dual-in-line hermetic (frit-seal) ceramic package.

The transistors of the CA3086 are well suited to a wide where the second The CA3086 is supplied in a 14-lead dual-in line plastic

MAXIMUM RATINGS, Absolute-Meximus	m Values at T _A = 25 ^o C
DISSIPATION:	

Any one transistor	300	mw
Total package up to T _A = 55 ^o C	750	mW
Above TA = 55°C	derate linearly 6.67	m₩/ºC
AMBIENT TEMPERATURE RANGE:		_
Operating	-55 to + 125	°c
Storage	-65 to + 150	°c
LEAD TEMPERATURE (During soldering):	•	
At distance 1/16 ± 1/32 inch (1.59 ± 0.79mm) From case for 10 seconds max	+ 265	°c.
The following ratings apply for each transistor in the device:		
COLLECTOR-TO-EMITTER VOLTAGE, VCEO	15	v
COLLECTOR TO BASE VOLTAGE, VCBO	20	v
COLLECTOR TO-SUBSTRATE VOLTAGE, VCIO*	20	v
EMITTER-TO-BASE VOLTAGE, VEBO	5	V.
COLLECTOR CURRENT, IC	50	mA -

¹ The collector of each transistor in the CA3086 is isolated from the substrate by an integral diode. The substrate (terminal 13) must be connected to the most negative point in the external circuit to maintain isolation between transistors and to provide for normal transistor action. To avoid undesirable coupling between transistors, the substrate (terminal 13) should be maintained at either DC or signal (AC) ground. A suitable bypass capacitor can be used to establish a signal ground.

ELECTRICAL CHARACTERISTICS at TA = 25°C

ي المعرف ا		TEST CONDITION					
CHARACTERISTICS	SYMBOLS		Typ. Charac-			UNITS	
			teristic Curves Fig. No.	Min.	Тур.	Max.	
Collector-to-Base Breakdown Voltage	V _{(BR)CBO}	$I_{C} = 10 \mu\text{A}, I_{E} = 0$	-	20	60		v
Collector-to-Emitter Breakdown Voltage	V(BR)CEO	$lc = 1mA, l_B = 0$	-	15	24	1	V
Collector-to-Substrate Breakdown Voltage	V _{(BR)CIO}	$I_{C} = 10 \mu A, I_{CI} = 0$	-	20	60		ν.
Emitter-to-Base Breakdown Voltage	V(BR)EBO	$I_{E} = 10 \mu A, I_{C} = 0$	-	5	7	-	V
Collector-Cutoff Current	ГСВО	$V_{CB} = 10V, I_E = 0$	• 2	-	0.002	100	nA
Collector-Cutoff Current	ICEO	$V_{CE} = 10V, I_B = 0$	3	-	See Curve	5	μA
DC Forward-Current Transfer Ratio	hFE	$V_{CE} = 3V_{1}I_{C} = 1mA$	4	40	100	-	





Applications

- General-purpose use in signal processing systems operating in the DC to 120-MHz range
- Temperature compensated amplifiers
- See RCA Application Note, ICAN-5296 "Application of the RCA-CA3018 Integrated-Circuit Transistor Array" for suggested applications.



Fig. 1 - Schematic diagram. Note that the substrate (pin 13) must be connected to the lowest supply voltage.

TYPICAL STATIC CHARACTERISTICS FOR EACH TRANSISTOR





CA3086

ELECTRICAL CHARACTERISTICS at T_A = 25°C Typical Values Intended Only for Design Guidance

[ŀ	1	EST CONDITIONS					
CHARACTERISTICS	SYMBOL			Typ. Chara- teristics Curves Fig. No.	TYPICAL VALUES	UNITS		
DC Forward-Current	h _{FE}	V _{CE} = 3V	$I_C = 10 \text{ mA}$	4	100			
					0.715			
Base-to-Emitter Voltage	∨ _{8E}	V _{CE} = 3V	$V_{CE} = 3V$ $E = 1 mA$		VCE = 3V IE = 10mA		0.715	
VBE Temperature Coefficient	Δν _{βΕ} /Δτ	V _{CE} = 3V,	V _{CE} = 3V, I _C = 1mA		V _{CE} = 3V, I _C = 1mA		-1.9	mV/ºC
Collector-to-Emitter Saturation Voltage	V _{CEsat}	I _B = 1mA,	¹ C = 10mA	-	0.23	[*] V		
Noise Figure (low frequency)	NF	f = 1kHz, V 1 _C = 100μA	CE = 3V, , R _S = 1k Ω	-	3.25	dB		
Low-Frequency, Small-Signal Equivalent-Circuit Characteristics:								
Forward Current-Transfer Ratio	h _{fe}	÷	•	7	100	-		
Short-Circuit Input Impedance	h _{ie}	f = 1kHz, V	CE ^{= 3V, I} C ^{= 1mA}	7	3.5	kΩ		
Open-Circuit Output Impedance	hoe	1		7	15.6	μmho		
Open-Circuit Reverse-Voltage Transfer Ratio	h _{re}			7	1.8 X 10 ⁻⁴	-		
Admittance Characteristics:								
Forward Transfer Admittance	γ _{fe}	-		8	31 — j1.5	mmho		
Input Admittance	y _{ie}	f = 1MHz, V	/ _{CE} = 3V, I _C = 1mA	9	0.3 + j0.04	mmho		
Output Admittance	Yoe	1 .		10	0.001 + j0.03	mmho		
Reverse Transfer Admittance	·Yre	1		11,	See Curve	-		
Gain-Bandwidth Product	f _T	V _{CE} = 3V,	I _C = 3mA	12	550	MHz		
Emitter-to-Base Capacitance	C _{EBO}	V _{EB} = 3V,	le = 0	-	0.6	pF		
Collector-to-Base Capacitance	Ссво	V _{CB} = 3V,	I _C ≖ 0		0.58	pF		
Collector-to-Substrate Capacitance	c _{CIO}	V _{CI} = 3V, I	c ^{= 0}	-	2.8	pF		





Fig.7 -- Normalized h_{fe}, h_{ie}, h_{oe}, h_{re} vs I_C.



Fig.8 -- y_{fe} vs f.

CONDUCTANCE (94)

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Fig. 12-f_T vs I_C.



CA3096E, CA3096AE

N-P-N/P-N-P Transistor-Array IC

RCA-CA3096E and CA3096AE are general-purpose highvoltage silicon transistor arrays. Each array consists of five independent transistors (two p-n-p and three n-p-n types) on a common substrate, which has a separate connection. Independent connections for each transistor permit maximum flexibility in circuit design. Types CA3096AE and CA3096E are identical, except that the CA3096AE specifications include parameter matching and greater stringency in ICBO, ICEO, and VCE(SAT) (see Table I). CA3096E and CA3096AE are supplied in 16-lead dual-in-line plastic packages.

TABLE I- CA3096AE AND CA3096E ESSENTIAL DIFFERENCES*

RCA	RCA ICBO IC TYPE (nA) (n TYPE		l _C	EO A)	V _{CE} (V	(SAT) /)	V (m	10 V)	ا10 ¹ (مم)	
TYPE			p-n-p	n-p-n	p-n-p	n-p-n	p-n-p	n-p-n	p-n-p	
CA3096AE	40	- 40	100	-100	0.7	0.4	5	5	0.6	0.25
CA3096E	100	-100	1000	-1000	1.0	0.7	-	-	-	-

* Maximum values.

STATIC ELECTRICAL CHARACTERISTICS at $T_A = 25^{\circ}C$ (For Equipment Design)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	CA30	CA3096AE, CA3096E LIMITS				
		· · · · ·	Min.	Тур.	Max.			
For Fech n.o.o Transistor:								
Collector-Cutoff Current (CA3096AE)	ICBO	V _{CB} = 10 V, i _E = 0	-	0.0013	40	nA		
Collector-Cutoff Current (CA3096AE)	ICEO	VCE = 10 V, IB = 0	-	0.0055	100	nA		
Collector-Cutoff Current (CA3096E)	ICBO	V _{CB} = 10 V, I _E = 0	-	0.0013	100	nA		
Collector-Cutoff Current (CA3096E)	ICEO	VCE = 10 V, IB = 0	-	0.0055	1	μΑ		
Collector-to-Emitter Breakdown Voltage	V(BR)CEO	I _C = 1 mA, I _B = 0	35	50	-	v		
Collector-to-Base Breakdown Voltage	V(BB)CBO	Ic = 10 μA, IE = 0	45	100	-	v		
Collector-to-Substrate Breakdown Voltage	V(BB)CIO	I _{CI} = 10 μA, I _B = I _E = 0	45	100	-	v		
Emitter-to-Base Breakdown Voltage		IF = 10 μA, IC = 0	6	8	-	v		
Emitter-to-Base Zener Voltage	V7	l _Z = 10 μA	6	7.9	9.8	v		
Collector-to-Emitter Saturation Voltage		N						
(CA3096AE)	VCE(SAT)	I _C = 10 mA, I _B = 1 mA	_ ·	0.24	0.5	v		
Collector-to-Emitter Saturation Voltage								
(CA3096E)	VCE(SAT)	i _C = 10 mA, i _B = 1 mA	_	0.24	0.7	V		
Base-to-Emitter Voltage	VBE	ic = 1 mA. Vc∈ = 5 V	0.6	0.69	0.78	V		
DC Forward-Current Transfer Ratio	hFE		150	390	500			
Magnitude of Temperature Coefficient:						0		
VBE (for each transistor)	Δν _{βε} /Δτ	IC = 1 mA, VCE = 5 V	-	1.9	-	mV/Č		
For Each p-n-p Transistor:								
Collector-Cutoff Current (CA3096AE)	Ісво	V _{CB} = -10 V, 1 _E = 0	-	- 0.055	40	nA		
Collector-Cutoff Current (CA3096AE)	ICEO	VCE = -10 V, IB = 0		-0.12	100	nA		
Collector-Cutoff-Current (CA3096E)	ICEO	VCE = -10 V, IB = 0		-0.12	1	μΑ		
Collector-Cutoff-Current (CA3096E)	СВО	$V_{CB} = -10 V, I_E = 0$	_	-0.055	100	nA		
Collector-to-Emitter Breakdown Voltage	V(BR)CEO	I _C =100 μA, I _B = 0	-40	75	-	v		
Collector-to-Base Breakdown Voltage	V(BR)CBO	I _C = -10 μA, I _E = 0	-40	80		v		
Emitter-to-Base Breakdown Voltage	V(BR)EBO	I _E = -10 μA, I _C = 0	-40	-100	-	v		
Emitter-to-Base Zener Voltage	VZ .	i _Z = 10 μA	10	16	-	V.		
Emitter-to-Substrate Breakdown Voltage	V(BR)EIO	$I_{E1} = 10 \ \mu A, I_B = I_C = 0$	40	100	-	v		
Collector-to-Emitter Saturation Voltage	VCE(SAT)	$I_{C} = -1 \text{ mA}, I_{B} = -100 \mu\text{A}$	_	-0.16	-0.4	v		
Base-to-Emitter Voltage	VRF	Ic = -100 #A, VcF = -5 V	-0.5	-0.6	-0.7	v		
		I _C = -100 μA, V _{CE} = -5 V	40	85	200			
DC Forward-Current Transfer Ratio	hFE	Ic = -1 mA, VcE = -5 V	20	47	150			
Magnitude of Temperature Coefficient:								
VBE (for each transistor)	Δν _{ΒΕ} /Δτ	$I_{C} = -100 \mu$ A, $V_{CE} = -5 V$	-	-2.2	-	mV/°C		
For Transistors Q1 and Q2 (As a Differential A	mplifier): CA3	1096AE ONLY						
Absolute Input Offset Voltage			-	0.3	5	mV		
Abashuta Lagud Officet Current	lind		-	0.07	0.6	ШA		
Absolute Input Offset Voltage Temperature		VCE * 5 V, IC * I mA			†			
Coefficient				1.1		µv/°c		
For Transistors Q4 and Q5 (As a Differential A	096AE ONLY							
Absolute Input Offset Voltage	IV tol		-	0.15	5	m۷		
Absolute Input Offset Current				2	250	nA		
Absolute Input Offset Voltage Temperature		$= \frac{1}{100} = $		T				
Coefficient	Δτ		-	0.54	<u> </u>	µv/°c		

SUBSTRATE 9205-20308

Schematic Diagram

Features:

- Matched General-Purpose Transistors (CA3096AE Only)
- Input Offset Voltage ± 5 mV
- Input Offset Current:
- p-n-p Pair ± 250 nA max. @ I_C = -100 μA
- n-p-n Pair ±0.6 μA max. @ I_C = 1 mA
- High hFE
- n-p-n transistor: 150 min. @ IC = 1 mA
- p-n-p transistor: 40 min. @ IC = 100 µA
- High Breakdown Voltages:
- n-p-n transistor: V_{(BR)CEO} ≠ 35 V min; V_{(BR)CBO} = 45 V min.

p-n-p transistor: V(BR)CEO = 40 V min; V(BR)CBO =

40 V min.

- Separate Substrate Connection
- Low Noise Figure:
 - n-p-n transistor: 2.2 dB typ. at 1 kHz p-n-p transistor: 3 dB typ. at 1 kHz

Applications:

- Differential Amplifiers
- DC Amplifiers
- Sense Amplifiers
- Level Shifters
- Timers
- Lamp and Relay Drivers
 Thyristor Firing Circuits
- Temperature-Compensated Amplifiers
- Operational Amplifiers
- Operational Amplituers

AXIMUM RATINGS, Absolute Maxin	mum Values	at T_A = 2	s°с
	Each n-p-n Transistor	Each p-n-j Transisto	D
ollector-to-Emitter Voltage VCEO	35	- 40	v
collector-to-Base Voltage VCBO	45	- 40	v
collector-to-Substrate			
Voltage	45	45	v
mitter-to-Base Voltage VEBO	6	- 40	v
Collector Current IC	50	- 10	mA
Dissipation PD:			
Up to TA = 55 °C:			
Device (Total)	7	50	mW
Each Transistor	2	00	m₩
Above T _A = 55 °C	Derate Lin	early 6.67	m₩/ [−] C
Temperature Range:			•
Operating	55 1	io +125	٦° د
Storage	-65 1	o +150	°C
Lead Temperature (During Soldering)			
At distance 1/16 ± 1/32" .			
(1.59 ± 0.79 mm) from case for			۰.
10 seconds max	2	65	С
	.		
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Fig.1-Base-to-emitter zener characteristic (n-p-n).

CA3096E, CA3096AE

DYNAMIC ELECTRICAL CHARACTERISTICS at TA = 25°C

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	TYPICAL VALUES	UNITS	
er Fach n-p-n Transistor					
to se Figure (low frequency)	NF	$f = 1 \text{ kHz}, \text{ V}_{CE} = 5 \text{ V},$ IC = 1 mA, RS = 1 k Ω	2.2	dB	
Enquency Input Resistance	Ri	6 = 1.0 kHz V == 5 V	10	kΩ	
OW-Frequency, Input Resistance	Bo		80	kΩ	
Admittance Characteristics:	9fe		7.5		
Forward Transfer Admittance	Yte bre		-j13	mmno	
	9ie	f = 1 MHz, V _{CE} = 5 V,	2.2	mmh	
Input Admittance	Vie bie	I _C = 1 mA	j3.1		
	908	1	0.76	mmhc	
Output Admittance	Voe boe		j2.4	_	
		V _{CE} = 5 V, I _C = 1.0 mA	280	Мнг	
Gain-Bandwidth Product		V _{CE} = 5 V, I _C = 5 mA	335		
Emitter-to-Base Capacitance	CEB	VEB = 3 V	0.75	pr	
Collector-to-Base Capacitance	CCB	V _{CB} = 3 V	0.46	pt	
Collector-to-Substrate Capacitance	CCI	V _{C1} = 3 V	3.2	pi	
For Each a p.p. Transistor					
Noise Figure (low frequency)	NF	f = 1 kHz, $I_{C} = 100 \mu\text{A}, \text{Bs} = 1 \text{ k}\Omega$	3	d	
Desistance		f = 1 kHz, VCE = 5 V,	27	kS	
Low-Frequency input Resistance		ic = 100 μA	680	k	
Low-Frequency Output Resistance		VCE = 5 V, IC = 100 #A	6.8	мн	
Usin-Bandwidth Product	CER	VEB = -3 V	0.85	p	
Emitter-to-Base Capacitance	Ссв	V _{CB} = -3 V	2.25	P	
	Cei	V _{B1} = 3 V	3.05	P	



Fig.4-Transistor (n-p-n) h_{FE} as a function of

















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CA741, CA747, CA748, CA1458, CA1558 Types Operational Amplifiers

High-Gain Single and Dual Operational Amplifiers For Military, Industrial and Commercial Applications

The RCA-CA1458, CA1558 (dual types); CA741C, CA741 (single-types); CA747C, CA747 (dual types); and CA748C, CA748 (single types) are general-purpose, high-gain operational amplifiers for use in military, industrial, and commercial applications.

These monolithic silicon integrated circuit devices provide output short-circuit protection and latch-free operation. These types also feature wide common-mode and differential-mode signal ranges and have low-offset voltage nulling capability when used with an appropriately valued potentiometer. A 5megohm potentiometer is used for offset nulling types CA748C, CA748 (See Fig. 10); a 10-kilohm potentiometer is used for offset nulling types CA741C, CA741, CA747CE, CA747CG, CA747E, CA747G (See Fig. 9); and types CA1458, CA1558, CA747CT, have no specific terminals for offset nulling, Each type consists of a differential-input amplifier that effectively drives a gain and level-shifting stage having a complementary emitter-follower output.

This operational amplifier line also offers the circuit designer the option of operation with internal or external phase compensation.

Types CA748C and CA748, which are externally phase compensated (terminals 1 and 8) permit a choice of operation for improved bandwidth and slew-rate capabilities. Unity gain with external phase compensation can be obtained with a single 30-pF capacitor. All the other types are internally phase-compensated.

RCA's manufacturing process makes it possible to produce IC operational amplifiers with low-burst ("popcorn") noise characteristics. Type CA6741, a low-noise version of the CA741, gives limit specifications for burst noise in the data bulletin, File No. 530. Contact your RCA Sales Representative for information pertinent to other operational amplifier types that meet low-burst noise specifications.

- "G" Suffix Types-Hermetic Gold-CHIP in Dual-In-Line Plastic Package
- "E" Suffix Types-Standard Dual-In-Line Plastic Package
- "T" and "S" Suffix Types-TO-5 Style Package

Features:

- Input bias current (all types): 500 nA max.
- Input offset current (all types): 200 nA max.

Applications:

- Comparator
- DC amplifier
- Integrator or differentiator
- Multivibrator
- Narrow-band or band-pass filter
- Summing amplifier

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1a.-CA741CS,CA741CT,CA741S, & CA741T with internal phase compensation.



DC Supply Voltage (between V ⁺ and V ⁻ t	erm	inals):											
CA741C, CA747CA, CA748C, CA1458	≜													. 36 V
CA741, CA747*, CA748, CA1558* .								•						44 V
Differential Input Voltage										÷	÷	÷		±30 V
DC Input Voltage*											·			±15 V
Output Short-Circuit Duration.	÷			· .						÷		·		Indefinite
Device Dissipation:	-	-		•	•			•	•	•	•	÷	• •	
Up to 70°C (CA741C CA748C)														500 mW
Up to 75°C (CA741, CA748)	•		•	•	•	•	•••	•	•	•	•	•	•••	500 mW
Up to 30°C (CA747)	·	•	• •	•	·	•	• •	•	•	•	•	•	• •	800 mW
Un to 25°C (CA747C)	•	·	• •	•	·	·	• •	·	•	•	•	•	• •	800 mW
Lin to 30°C (CA1558)	·	•	• •	·	•	•	• •	•	•	•	•	•	• •	690 mW
$U_0 t_0 25^{\circ} C (CA1458)$	•	·	• •	·	•	•	•••	•	•	•	·	• '	• •	690 mW
For Temperatures Indicated Above	•	•	• •	•	•	•	• •	·	•		•	• • • • •	• •	6 67 mW/°C
Voltage between Offset Null and V= (CA)			741				· ·			06	au		earry	0.07 mm/ C
Ambient Temperature Banger	410	, 04	/41,	CA	470			+/00) ,	·	•	•	• •	. 10.5 V
Operating CA341 CA347E CA349	~ • •													- · · · · · · · · ·
Operating - CA741, CA747E, CA748,		000		•	·	•	• •	·	·	·	·	•	-5	5 to +125 C
CA/41C, CA/4/C, CA/4	5C, C	A14	58.	·	·	·	• •	·	٠	·	·	٠	_	0 to +/0 C'
Storage	·	·	• •	·	٠	·	• •	·	·	·	·	•	-6	5 to +150 C
Lead Temperature (During Soldering):	70.		••••			10								200 °C
At distance 1/10 ± 1/32 mcn (1.59 ± 0	./91	nm	mon	1 Case	e tor	10	seco	nasi	nax	•	•	•	• •	. 205 C
* If Supply Voltage is less than ± 15 volts,	the	Abso	olute	Max	imu	m lr	nput	Volt	age	is e	qua	l to	the S	Supply Volt-

Voltage values apply for each of the dual operational amplifiers.

[†] All types in any package style can be operated over the temperature range of -55 to +125°C, although the published limits for certain electrical specifications apply only over the temperature range of 0 to +70°C.



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1b.—CA747CT and CA747T with internal phase compensation.



1c.-CA748CS, CA748CT, CA748S, and CA748T with external phase compensation.

Fig: 1 - Functional diagrams.

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CA741, CA747, CA748, CA1458, CA1558 Types

RCA Type No.	No. of Ampl.	Phase Comp.	Offset Voltage Null	Min. A _{OL}	Max. V _{IO} (mV)	Operating-Temperature Range ([°] C)
CA1458	dual	int:	no	20k	6	0 to +70▲
CA1558	duat	int.	no	50k	5	-55 to +125
CA741C	single	int.	ves	20k	6	0 to +70≜
CA7410	single	int.	ves	50k	5	55 to +125
CA747C	dual	int.	ves*	20k	/ 6	0 to +70≜
CA747	dual	int.	ves*	50k	5	-55 to +125
CA748C	single	ext.	ves	20k	6	0 to +70≜
CA748	single	ext.	yes	50k	5	-55 to +125

*In the 14-lead dual-in-line plastic package only.

[▲]All types in any package style can be operated over the temperature range of -55 to +125°C, although the published limits for certain electrical specifications apply only over the temperature range of 0 to +70°C.

ORDERING INFORMATION

When ordering any of these types, it is important that the appropriate suffix letter for the package required be affixed to the type number. For example: If a CA1458 in a straight-lead TO-5 style package is desired, order CA1458T.

			PACKAG	E TY	PE A	ND SL	FFIX	LETT	ÉR		
Type No.	TO-5 STYLE			PLASTIC		Gold-CHIP PLASTIC		CHIP	Gold- CHIP	BEAM- LEAD	FIG. No.
	8L	10L	DIL-CAN	8L	14L	8L	14L				
CA1458	т		S	Ė		G		н	GH		1d, 1h
CA1558	Т	<u> </u>	S	E		G					1d, 1h
CA741C	т	†	S	Е	[G		н	GH		1a, 1e
CA741	Т		S	E		G				L	1a, 1e
CA747C		Т		1	E	1	G	н	GH		1b, 1f
CA747		Т			E		G				1b, 1f
CA748C	T		s	E	1	G		н	GH		1c, 1g
CA748	T		S	E		G					1c, 1g



Fig.2—Schematic diagram of operational amplifier with external phase compensation for CA748C and CA748.



1d. – CA1458S, CA1458T, CA1558S, and CA1558T and internal phase compensation.



1e.-CA741CE,CA741CG,CA741E, and CA741G with internal phase compensation.



1f.—CA747CE,CA747CG,CA747E, and CA747G with internal phase compensation.



1g.-CA748CE,CA748CG,CA748E, and CA748G with external phase compensation.



phase compensation.

Fig. 1 - Functional Diagrams (Cont'd)

CA741, CA747, CA748, CA1458, CA1558 Types



Fig.3–Schematic diagram of operational amplifiers with internal phase compensation for CA7410 CA741, and for each amplifier of the CA747C, CA747, CA1458, and CA1558. ELECTRICAL CHARACTERISTICS

For Equipment Design

	TEST CONDI	TIONS		LIMITS		
	Supply Voltage $V^+ = 15 V$.	je ,		CA741		
CHARACTERISTIC	V- = -15 V	-:		CA747*		UNITS
	Ţ.	Ambient		CA1558*		
		Temperature, T _A	Min.	Тур.	Max.	
Input Offset Voltage Vio	Rc = ≤ 10 kΩ	25 °C	-	1	5	mV
	3	–55 to +125 °C	_	1	6	
		25 °C	-	20	200	
Input Offset Current, IIO		–55 °C	1	85	500	nA
		+125 °C	— ,	7	200	1. 1.
		25 °C	. –	80	500	
Input Bias Current, I _{IB}		–55 °C	_	300	1500	nA
		+125 °C	-	30	500	
Input Resistance, R			0.3	2	-	MΩ
Open-Loop Differential	R _L ≥2kΩ	25 °C	50,000	200,000	-	
Voltage Gain, A _{OL}	V _O =±10V	-55 to +125 °C	25,000	<u>-</u>	-	
Common-Mode Input Voltage Range, V _{ICR}	·	–55 to +125 °C	±12	±13	-	V
Common-Mode Rejection Ratio , CMRR	R _S ≤10kΩ	–55 to +125 °C	70	90	-	dB
Supply Voltage Rejection Ratio, PSRR	R _S ≤10kΩ	–55 to +125°C	-	30	150	μ V/ V
Output Voltage	R _L ≥10kΩ	–55 to +125 °C	±12	±14	-	v
Swing, VOPP	R _L ≥2kΩ	–55 to +125 °C	±10	±13	-	
		25 °C	-	1,7	2.8	
Supply Current, I [±]		−55 °C	-	2	3.3	mA
		+125 °C	-	1.5	2.5	
×		25 °C	_	50	85	
Device Dissipation, PD		–55 °C	+	60	100	mW
		+125 °C	- ·	45	75	



Fig.7—Peak-to-peak output voltage vs. supply voltage for all types except CA748 and CA748C.

* Values apply for each section of the dual amplifiers.

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CA741, CA747, CA748, CA1458, CA1558 Types

LECTRICAL CHARACTERISTICS

or Equipment Design

or Edulphingur Porigi						
	TEST CONDITI	ONS		MITS		
	Supply Voltage,			4/41C 4747C*		· 1
CHARACTERISTIC	V ⁺ = 15 V, V = -15 V	Ambient Temperature, To	C/ C/	A748C A1458*		UNITS
			Min.	Тур.	Max.	
	0 <1010	25 °C	-	2	6	mV
VIO	HS=#10K32	0 to 70 °C	-	-	7.5	
Land Officer Coursest		25 °C	_	20	200	nA
Input Offset Current,		0 to 70 °C	-	· _	300	
Input Bias Current		25 °C		80	500	nA
¹ 1B		0 to 70 °C	· -	-	800	
Input Resistance, R ₁			0.3	2		MΩ
Open-Loop Differential	R _L ≥2kΩ	25 °C	20,000	200,000	_	
Voltage Gain, AOL	V _O = ±10 V	0 to 70 °C ·	15,000	. 1	-	
Common-Mode Input Voltage Range, V _{ICR}		25 °C	±12	±13	-	v
Common-Mode Rejection Ratio, CMRR	R _S ≤10kΩ	25 °C	70	90	_	dB
Supply-Voltage Rejection Ratio, PSRR	R _S ≤10kΩ	25 °C	_	30	150	μV/V
	R _L ≥10 kΩ	25 °C	±12	±14		
Output Voltage Swing,		25 °C	±10	±13	-	V
* OFF	μΓ ⇒ ΣκΩ	0 to 70 °C	±10	±13	-	
Supply Current, I [±]		25 °C	-	1.7	2.8	mA
Device Dissipation, PD		25 °C	-	50	85	mW



Fig.8—Output voltage vs. transient response time for CA741C and CA741.



Fig.9–Voltage-offset null circuit for CA741C, CA741, CA747CE, CA747CG, CA747E, and CA747G.



Fig.10—Voltage-offset null circuit for CA748C and CA748.



Fig. 11-Transient response test circuit for all types.

* Values apply for each section of the dual amplifiers.

ELECTRICAL CHARACTERISTICS Typical Values Intended Only for Design Guidance

CHARACTERISTIC	TEST CONDITIONS V± = ±15 V	TYP. VALUES ALL TYPES	UNITS
Input Capacitance, Cl		1.4	pF
Offset Voltage Adjustment Range		±15	mV
Output Resistance, RO		75	Ω
Output Short-Circuit Current		25	mA
Transient Response: Rise Time, t _r	Unity gain V _I = 20 mV	0.3	μs
Overshoot	RL = 2 kΩ CL ≤ 100 pF	5	%
Slew Rate, SR: Closed-loop	P. > 2 KO	0.5	V/us
Open-loop [▲]		40	

▲ Open-loop slew rate applies only for types CA748C and CA748.

TYPES 2N3905, 2N3906, A5T3905, A5T3906 P-N-P SILICON TRANSISTORS

BULLETIN NO. DL-S 7311577, NOVEMBER 1971-REVISED MARCH 1973

SILECT[†] TRANSISTORS[‡]

FOR GENERAL PURPOSE SATURATED-SWITCHING AND AMPLIFIER APPLICATIONS

- For Complementary Use with N-P-N Types 2N3903, 2N3904, A5T3903, and A5T3904
- Rugged One-Piece Construction with In-Line Leads or Standard TO-18 100-mil Pin-Circle Configuration

mechanical data

These transistors are encapsulated in a plastic compound specifically designed for this purpose, using a highly mechanized process developed by Texas Instruments. The case will withstand soldering temperatures without deformation. These devices exhibit stable characteristics under high-humidity conditions and are capable of meeting MIL-STD-202C, Method 106B. The transistors are insensitive to light.



absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)

Collector-Base Voltage			· · · · · -40 V* · · · · · -40 V*
Emitter-Base Voltage			
Continuous Collector Current	· · · · · · · ·	• • • • • • • • •	–200 mA*
Continuous Device Dissipation at (or below) 25° C Fre	e-Air Temperature (S	(See Note 2)	· · · { 310 mW*
Storage Temperature Range			$\begin{cases} -65^{\circ}C \text{ to } 150^{\circ}C \\ -55^{\circ}C \text{ to } 135^{\circ}C^{*} \end{cases}$
Lead Temperature 1/16 Inch from Case for 60 Second	ls		· · · {260°C§ 230°C*

NOTES: 1. This value applies between 10 µA and 200 mA collector current when the base-emitter diode is open-circuited.

Derate the 625-mW rating linearly to 150°C free-air temperature at the rate of 5 mW/°C. Derate the 310-mW (JEDEC registered) rating linearly to 135°C free-air temperature at the rate of 2.81 mW/°C.

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*The asterisk identifies JEDEC registered data for the 2N3905 and 2N3906 only. This data sheet contains all applicable registered data in effect at the time of publication.

IEXAS INSTRUMENTS

INCORPORATED POST OFFICE BOX 5012 + DALLAS, TEXAS 75222

[‡]U.S. Patent No. 3,439,238

 ${}^{\$}$ Texas Instruments guarantees these values in addition to the JEDEC registered values which are also shown.

USES CHIP P15

TYPES 2N3905, 2N3906, A5T3905, A5T3906 P-N-P SILICON TRANSISTORS

electrical	characteristics at 25 C free-a	ir temperatu	16						
		·			2N3	3905	2N3906		
	PARAMETER	TE	ST CONDITION	IS	A5T	3905	A5T	3906	UNIT
				1	MIN	MAX	MIN	MAX	
V(BR)CBO	Collector-Base Breakdown Voltage	$I_{\rm C} = -10 \mu {\rm A},$	IE = 0		-40		-40		V
V(BR)CEO	Collector-Emitter Breakdown Voftage	$I_{C} = -1 \text{ mA},$	$I_{B} = 0,$	See Note 3	-40		-40		V
V(BR)EBO	Emitter-Base Breakdown Voltage	1 _E = -10 μA,	I _C = 0		-5		-5		V
ICEV	Collector Cutoff Current	$V_{CE} = -30 V$,	V _{BE} = 3 V			-50		-50	nA
IBEV	Base Cutoff Current	$V_{CE} = -30 V$,	V _{BE} = 3 V			50		50	nA
		$V_{CE} = -1 V$,	$I_C = -100 \ \mu A$		30		60		
		$V_{CE} = -1 V$,	$I_C = -1 \text{ mA}$		40		80		
hFE	Static Forward Current Transfer Ratio	$V_{CE} = -1 V$,	$I_{C} = -10 \text{ mA}$		50	150	100	300	
		$V_{CE} = -1 V$,	$I_{C} = -50 \text{ mA}$	See Note 3	30		60		
		$V_{CE} = -1 V$,	$I_{C} = -100 \text{ mA}$]	15		30		
	Pasa Emittar Voltage	$I_{B} = -1 \text{ mA},$	$I_{C} = -10 \text{ mA}$	See Note 2	-0.65	-0.85	-0.65	-0.85	V
▲BE	Dase-Childer Voltage	I _B = -5 mA,	$I_{C} = -50 \text{ mA}$	See Note S		-0.95		-0.95	
VCE(ant)	Collector Emitter Seturation Voltage	I _B = -1 mA,	$I_{C} = -10 \text{ mA}$	See Nets 2		-0.25		-0.25	V
VCE(sat)	Conector-Emitter Saturation Voltage	$I_{B} = -5 \text{ mA},$	$I_{C} = -50 \text{ mA}$	See Note S		-0.4		-0.4	
b.	Small-Signal Common-Emitter				0.5	0	2	10	10
nie	Input Impedance	$V_{05} = -10 V$			0.5	0	2	12	K22
h.,	Small-Signal Common-Emitter	- VCE 10 V,			50	200	100	400	
nfe	Forward Current Transfer Ratio		$lo = 1 m \Lambda$		50	200	100	400	
	Small-Signal Common-Emitter]	C = -1 mA,		0.1 X	5 X	0.1 X	10 ×	
nre	Reverse Voltage Transfer Ratio				10-4	10-4	10-4	10-4	
L.	Small-Signal Common-Emitter	1		f = 1 kHz	1	40	2	<u> </u>	
n _{oe}	Output Admittance				· ·	40	3	60	μmno
In 1	Small-Signal Common-Emitter	V	1 10 - 0	(- 100 MIL			0.5		
n _{fe}	Forward Current Transfer Ratio	VCE = -20 V,	$I_{C} = -10 \text{ mA},$	t = 100 WH2	2		2.5		- 9 - I
fт	Transition Frequency	V _{CE} = -20 V,	$I_{C} = -10 \text{ mA},$	See Note 4	200		250		MHz
0	Common-Base Open-Circuit	$V_{CB} = -5 V_{,}$	IE = 0,			4.5			-
Cobo	Output Capacitance	f = 100 kHz to	1 MHz			4.5		4.5	p⊦
0	Common-Base Open-Circuit	$V_{EB} = -0.5 V$,	I _C = 0,			10			-
Cibo	Input Capacitance	f = 100 kHz to 1 MHz				10		10	pF

*electrical characteristics at 25°C free-air temperature

NOTES: 3. These parameters must be measured using pulse techniques. t_w = 300 μ s, duty cycle \leq 2%.

4. To obtain f_T , the $|h_{fe}|$ response is extrapolated at the rate of -6 dB per octave from f = 100 MHz to the frequency at which $|h_{fe}| = 1$.

*operating characteristics at 25°C free-air temperature

PARAMETER		TEST CONDITIONS			2N3905 A5T3905		2N3906 A5T3906		
		`,				MAX	MIN	MAX	AX
NF	Average Noise Figure		$V_{CE} = -5 V,$ $R_G = 1 k\Omega,$ See Note 5	$I_{C} = -100 \ \mu A$, Noise Bandwidth = 15.7 kHz,		5		4	dB

NOTE 5: Average Noise Figure is measured in an amplifier with response down-3 dB at 10 Hz and 10 kHz and a high-frequency rolloff of 6 dB/octave.

*The asterisk identifies JEDEC registered data for the 2N3905 and 2N3906 only.

BULLETIN NO. DL-S 7311916, MARCH 1973

DESIGNED FOR HIGH-SPEED, MEDIUM-POWER SWITCHING AND GENERAL PURPOSE AMPLIFIER APPLICATIONS

- hFE... Guaranteed from 100 µA to 500 mA
- High f_T at 20 V, 20 mA . . . 300 MHz (2N2219A, 2N2222A) 250 MHz (all others)
- 2N2218, 2N2221 for Complementary Use with 2N2904, 2N2906
- 2N2219, 2N2222 for Complementary Use with 2N2905, 2N2906

*mechanical data

Device types 2N2217, 2N2218, 2N2218A, 2N2219, and 2N2219A are in JEDEC TO-5 packages. Device types 2N2220, 2N2221, 2N2221A, 2N2222, and 2N2222A are in JEDEC TO-18 packages.



*absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)

	2N2217 2N2218 2N2219	2N2218A 2N2219A	2N2220 2N2221 2N2222	2N2221A 2N2222A	UNIT
Collector-Base Voltage	60	75	60	75	V
Collector-Emitter Voltage (See Note 1)	30	40	30	40	V
Emitter-Base Voltage	5	6	5	6	V
Continuous Collector Current	0.8	0.8	0.8	0.8	A
Continuous Device Dissipation at (or below) 25°C Free-Air Temperature (See Notes 2 and 3)	0.8	0.8	0.5	0.5	w
Continuous Device Dissipation at (or below) 25°C Case Temperature (See Notes 4 and 5)	3	3	1.8	1.8	w
Operating Collector Junction Temperature Range	-65 to 175				°C
Storage Temperature Range	-65 to 200				°C
Lead Temperature 1/16 Inch from Case for 10 Seconds		2	30		°C

NOTES: 1. These values apply between 0 and 500 mA collector current when the base-emitter diode is open-circuited.

2. Derate 2N2217, 2N2218, 2N2218A, 2N2219, and 2N2219A linearly to 175°C free-air temperature at the rate of 5.33 mW/°C.

3. Derate 2N2220, 2N2221, 2N2221A, 2N2222, and 2N2222A linearly to 175°C free-air temperature at the rate of 3.33 mW/°C.

4. Derate 2N2217, 2N2218, 2N2218A, 2N2219, and 2N2219A linearly to 175°C case temperature at the rate of 20.0 mW/°C.

5. Derate 2N2220, 2N2221, 2N2221A, 2N2222, and 2N2222A linearly to 175°C case temperature at the rate of 12.0 mW/°C.

*JEDEC registered data. This data sheet contains all applicable registered data in effect at the time of publication.

2N2217 THRU 2N2222

*electrical characteristics at 25°C free-air temperature (unless otherwise noted)

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			T0-5 →	2N	2217	2N	2218	2N2219		
	FARAMETER	TEST CONDITIONS	TO-18 →	2N:	2220	2N	2221	2N	2222	UNIT
	Collector Bass		······	MIN	MAX	MIN	MAX	MIN	MAX	
V(BR)CBC	Breakdown Voltage	$I_{C} = 10 \ \mu A, I_{E} = 0$		60		60		60		v
V(BR)CEC	Collector-Emitter Breakdown Voltage	I _C = 10 mA, I _B = 0,	See Note 6	30		30	·····	30		v
V(BR)EBO	Emitter-Base Breakdown Voltage	$I_{E} = 10 \ \mu A, I_{C} = 0$	<u> </u>	5		5		5		v
ICBO	Collector Cutoff	$V_{CB} = 50 V, I_E = 0$		†	10		10		10	
	Current	$V_{CB} = 50 V, I_E = 0,$	$T_{A} = 150^{\circ}C$	†	10		10		10	nA
^I EBO	Emitter Cutoff Current	$V_{EB} = 3 V, I_{C} = 0$			10		10		- 10	μΑ
		$V_{CE} = 10 V$, $I_{C} = 100 \mu A$				20		35		
	Statia Essent O	$V_{CE} = 10 V$, $I_{C} = 1 mA$		12		25		50		Ę
hFE	Static Forward Current	$V_{CE} = 10 V, I_{C} = 10 mA$	· · · · · · · · · · · · · · · · · · ·	17		35		75		51 - 4 June 1
	Transfer Ratio	$V_{CE} = 10 V, I_{C} = 150 mA$	Co. N. C.	20	60	40	120	100	300	
		$V_{CE} = 10 V, I_{C} = 500 mA$	See Note 6			20		30		12 APRIL 10
		$V_{CE} = 1 V$, $I_{C} = 150 mA$		10		20		50		
V _{BE} Ba	Base-Emitter Voltage	$I_{B} = 15 \text{ mA}, I_{C} = 150 \text{ mA}$	See Note 6		1.3		1.3		13	
		$I_{B} = 50 \text{ mA}, I_{C} = 500 \text{ mA}$	See Note 6				26		26	V
V _{CE(sat)}	Collector-Emitter	$I_{B} = 15 \text{ mA}, I_{C} = 150 \text{ mA}$			0.4		0.4		2.0	
	Saturation Voltage	$I_{B} = 50 \text{ mA}, I_{C} = 500 \text{ mA}$	See Note 6				1.6		1.6	v
	Small-Signal						+		+	
h _{fe}	Common-Emitter									80 °61 - 14
	Forward Current	• CE = 20 •, 1C = 20 mA, •	T = 100 MHz	2.5		2.5		2.5		
<u> </u>	Transfer Ratio									
[†] T	Transition Frequency	$V_{CE} = 20 V, I_C = 20 mA, S$	See Note 7	250		250		250		A ALL
	Common-Base						·	250		MH2
Cobo	Open-Circuit	$V_{CB} = 10 V, I_E = 0, 1$	f = 1 MHz		8					-
	Output Capacitance	_			Ŭ		0		8	pF
	Real Part of					······				
histraal	Small-Signal		Í				ļ			and the second
··ie(real)	Common-Emitter	$V_{CE} = 20 V, I_{C} = 20 mA, f$	= 300 MHz		60		60		60	Ω
·····	Input Impedance		ļ							
			1		1		1		1	1

NOTES: 6. These parameters must be measured using pulse techniques. $t_W = 300 \ \mu$ s, duty cycle $\leq 2\%$.

7. To obtain f_T , the $|h_{fe}|$ response with frequency is extrapolated at the rate of -6 dB per octave from f = 100 MHz to the frequency at which $|h_{fe}| = 1$.

switching characteristics at 25°C free-air temperature

	PARAMETER	TEST CONDITIONS		1.
td	Delay Time		Түр	UNIT
t _r	Rise Time		, 5	ns
ts	Storage Time	$\qquad \qquad $	15	ns
tf	Fall Time		190	ns
L		¹ B(2) = -15 mA, See Figure 2	23	ns

[†]Voltage and current values shown are nominal; exact values vary slightly with transistor parameters.

*JEDEC registered data

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2N2218A, 2N2219A, 2N2221A, 2N2222A

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*electrical characteristics at 25°C free-air temperature (unless otherwise noted)

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			TO-5 →	2N	12218A	2N	2219A	
	PARAMETER	TEST CONDITIONS	TO-18 →	2N	12221A	2N	2222A	UNIT
				MIN	MAX	MIN	MAX	
V(BR)CBO	Collector-Base Breakdown Voltage	$I_{C} = 10 \ \mu A$, $I_{E} = 0$		75		75		V
V(BR)CEO	Collector-Emitter Breakdown Voltage	I _C = 10 mA, I _B = 0,	See Note 6	40		40		V
V(BR)EBO	Emitter-Base Breakdown Voltage	$I_E = 10 \ \mu A$, $I_C = 0$		6		6		V
lono	Collector Cutoff Current	V _{CB} = 60 V, I _E = 0			10		10	nA
ICBO		V _{CB} = 60 V, 1 _E = 0,	T _{A_} = 150°C		10		10	μA
ICEV	Collector Cutoff Current	V_{CE} = 60 V, V_{BE} = -3 V			10		10	nA
IBEV	Base Cutoff Current	$V_{CE} = 60 V, V_{BE} = -3 V$			-20		-20	nA
IEBO	Emitter Cutoff Current	V _{EB} = 3 V, I _C = 0			10		10	ņΑ
		$V_{CE} = 10 V, I_{C} = 100 \mu A$		20		35		
		V _{CE} = 10 V, I _C = 1 mA		25		50]
		V _{CE} = 10 V, I _C = 10 mA		35		75].
hFE	Static Forward Current	$V_{CE} = 10 V$, $I_{C} = 150 mA$		40	120	100	300	
	Transfer Ratio	V _{CE} = 10 V, I _C = 500 mA	See Note 6	25		40		
		V _{CE} = 1 V, I _C = 150 mA		20		50		1
		V _{CE} = 10 V, I _C = 10 mA,		15	* i	35	- · .	
		T _A = −55°C		15		55		
Ver Base-	Base-Emitter Voltage	I _B = 15 mA, I _C = 150 mA	See Note 6	0.6	1.2	0.6	1.2	
•BE	VBE Base-Emitter Voltage	1 _B = 50 mA, 1 _C = 500 mA	See Note o		2		2] `
Voru	Collector Emitter Saturation Voltage	I _B = 15 mA, I _C = 150 mA	See Note 6		0.3		0.3	V
*CE(sat)		I _B = 50 mA, I _C = 500 mA	See NOLE O		1		1] `
h	Small-Signal Common-Emitter	V _{CE} = 10 V, I _C = 1 mA		1	3.5	2	8	ko
''ie	Input Impedance	$V_{CE} = 10 V$, $I_{C} = 10 mA$		0.2	1	0.25	1.25	K32
he	Small-Signal Forward Current	V _{CE} = 10 V, I _C = 1 mA		30	150	50	300	
l "fe	Transfer Ratio	V _{CE} = 10 V, I _C = 10 mA	f - 1 1.11-	50	300	75	375	1
	Small-Signal Common-Emitter	V _{CE} = 10 V, I _C = 1 mA	T = T KMZ		5x10 ⁻⁴	1	8×10 ⁴	
n're	Reverse Voltage Transfer Ratio	V _{CE} = 10 V, I _C = 10 mA			2.5x10 ⁴		4x10 ⁴	1
L	Small-Signal Common-Emitter	V _{CE} = 10 V, I _C = 1 mA		3	15	5	35	1
noe	Output Admittance	V _{CE} = 10 V, I _C = 10 mA		10	100	25	200	μmho
	Small-Signal Common-Emitter	V	(- 100 MU-	0.5			Mallari	1
¹ fe	Forward Current Transfer Ratio	$v_{CE} = 20 v, I_C = 20 mA,$	T = TUU MHZ	2.5		3		
fT	Transition Frequency	$V_{CE} = 20 V, I_{C} = 20 mA,$	See Note 7	250		300		MHz
Cata	Common-Base Open-Circuit	$V_{\text{op}} = 10 V_{\text{op}} = 0$	f = 100 kHz		0		0	- 5
-000	Output Capacitance				0		d	рг
Cite	Common-Base Open-Circuit		f = 100 kH-		2F			-r
	Input Capacitance	EB = 0.0 v, IC = 0,			25		25	p⊷
b:	Real Part of Small-Signal	$V_{0} = 20 V_{0} = 20 = 4$	f - 200 MU-					
''ie(real)	Common-Emitter Input Impedance	V CE = 20 V, IC = 20 mA,	1 - SUU WIEIZ		60		60	52
r _b ′С _с	Collector-Base Time Constant	$V_{CE} = 20 V, I_{C} = 20 mA,$	f = 31.8 MHz		150		150	ps

NOTES: 6. These parameters must be measured using pulse techniques. $t_w = 300 \ \mu s$, duty cycle $\leq 2\%$.

7. To obtain f_T, the |h_{fe}| response with frequency is extrapolated at the rate of -6 dB per octave from f = 100 MHz to the frequency at which |h_{fe}| = 1.

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*operating characteristics at 25°C free-air temperature

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PARAMETER			TO-5 →	2N2218A	2N2219A	
		TEST CONDITIONS	TO-18 →	2N2221A	2N2222A	UNIT
Ì	E Spot Noise Eigure			MAX	MAX	
1		$V_{CE} = 10 V$, $I_{C} = 100 \mu A$, $R_{G} = 1 k\Omega$, f	f = 1 kHz		4	dB

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*switching characteristics at 25°C free-air temperature

	PARAMETER	TEST CONDITIONS [†]	TO-5 - TO-18	→ 2N2218A → 2N2221A	2N2219A	
	Datas T			MAX	MAX	
L'd		$V_{CC} = 30 V$ $I_{C} = 150 mA$		10	10	05
Lr	Rise Time	$V_{\text{DEV}} = -0.5 \text{ V}$	¹ B(1) = 15 mA	25	25	
TΑ	Active Region Time Constant [‡]	• BE (off) = -0.5 V,	See Figure 1	25		
ts	Storage Time	$V_{CC} = 30 V$ $I_{C} = 150 - 0$		2.5	2.5	ns
te	Fall Time	1 - CC = 150 mA,	^I B(1) = 15 mA,	225	225	ns
-1		$I_{B(2)} = -15 \text{ mA},$	See Figure 2	60	60	ns

[†]Voltage and current values shown are nominal; exact values vary slightly with transistor parameters.

[‡]Under the given conditions τ_A is equal to $\frac{t_r}{10}$



- NOTES: a. The input waveforms have the following characteristics: For Figure 1, $t_r \le 2$ ns, $t_W \le 200$ ns, duty cycle $\le 2\%$; for Figure 2, $t_f \le 5$ ns, $t_W \approx 100 \ \mu$ s, duty cycle $\le 17\%$.
 - b. All waveforms are monitored on an oscilloscope with the following characteristics: $t_r \le 5$ ns, $R_{in} \ge 100$ k Ω , $C_{in} \le 12$ pF.

Standard Component Values

STANDARD 1/4 WATT RESISTANCE VALUES 5%

OHMS	OHMS	OHMS	OHMS	OHMS	OHIMS	OHMS	OHMS	OHMS	OHMS	OHMS
2.2	9.1	-> 39	160	-→680	3000	-312K	→ 51K	-⇒220K	910K	-→3.9M
2.4	→10	43	180 جہ '	750		13K	→56K	240K	->1.0M	4.3M
2.7	11	->47	→ 200		3600	→ 15K	62K	-→270K	1.1M	->4.7M
3.0		51	-> 220		>3900	16K	-→ 68K	300K	>1.2M	5.1M
-> 3.3	->13	-> 56	240	->1000	4300	→ 18K	75K	→ 330К	1.3M	>5.6M
3.6	->15	— <u>></u> 62	-> 270	->1100	→4700	—∋ 20K	>> 82K	360K	→1 5M	>6.2M
3.9	16	->68		->1200	- → 5100	-> 22K	-→ 91K	-→ 390K	1.6M	6.8M
4.3	→18	75		->1300	→5600	-> 24K	-→100К	-→ 430K	→1.8M	
4.7	20	> 82	360	>+500	6200	->27K	110K	_>470K		
5.1	<u>→22</u>	91	- ⇒390	1600	>6800	30K	->120К	510K	→ 2.2M	9.1M
	24		430	->1800	7500	-→33K	-⇒130K		2.4M	-> 10M
6.2	27	110		>2000	→8200	-⇒36K	-→150K	-→620K	-⇒2.7M	
6.8	30	->120	<u> </u>	->2200	9100	_⇒39K	160K	> 680K	3.0M	
7.5	-→33	130		2400	-→ 10K	43K	-⇒180K	→750K	→ 3.3M	
8.2	36	- <u>-</u> ⇒150	620	>2700	11K	->47K	200K	-→820K	3.6M	

Standard Capacitor Values

DF	pF	υF	μF	μF	μF	μF	μF
10	→100	→.001 -	>.01	->.10	->1	->10	>100
12	-→120	.0012	.012	.12			
15	150	.0015	.015	.15	1.5	15	
18	180	.0018	.018	.18	a2.0		
20	<u>→200</u>	→.002 -	∋.02	.2		\	
→ 22	→220	.0022	.022	<i>→</i> .22	2.2	->22	220
<i>→</i> 25		.0025	.025	.25			
27	→270	.0027	.027	->.27			-
-> 33	-> 3 0 0	→.0033 -	→.030	<i>→</i> .33	<i>→</i> 3.3	->33	
->39	→390	.0039	.039	. 39			
→47	→470		→.047	<i>→</i> .47	→4.7	>47	4/0
50	500	.005 -	→.05	.5			
56	560	.0056	.056	.56			
->68	680		→.068	.68	6.8		
75	750	.0075	.075	.75			
<u>>82</u>	820	.0082	.082	.82			

1 % RESISTORS

U3 2 D	2.15 KA	232KN
498 D	26.7 KA	267KN
n 1 50	29.2 KA	332 KN
93.10C	30.9 KN	340 KN

> points to parts in stock.